

Search Notes

Application/Control No.

10/763,434

Examiner

Ardith E. Hertzog

Applicant(s)/Patent under
Reexamination

OSTERLOH, JAMES

Art Unit

1754

SEARCHED

Class	Subclass	Date	Examiner
588	900	6/1/2005	AEH
588	299, 401	6/2/2005	AEH
588	249.5	6/2/2005	AEH
510	110	6/2/2005	AEH
222	83, 87	6/7/2005	AEH
141	90, 91	6/7/2005	AEH
100	73, 98R	6/7/2005	AEH
100	104	6/7/2005	AEH
141	65	6/7/2005	AEH
86	49, 50	6/7/2005	AEH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
eDAN inventor search	5/6/2005	AEH
STIC Search of NPL+ databases (see attached printout)	5/13/2005	AEH
EAST searches of USPAT/USPGPUB (including PLUS 6/3/2005) &/or JPO/EPO/DERWENT/IBM_TDB databases (see attached strategy)	6/1, 2, 7, 8 2005	AEH
consulted Primary Examiner E. Leigh McKane re possible class 422 apparatus search: no search required	6/6/2005	AEH